## Notice of References Cited

Application/Control No.

10/797,082

Examiner

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Applicant(s)/Patent Under
Reexamination
ONISHI ET AL.

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,213,272	04-2001	Braford, Jr., Thomas E.	192/87.11
	В	US-4,640,294	02-1987	Ordo, Richard A.	192/70.2
	С	US-6,374,687	04-2002	Tanizawa et al.	192/87.11
	D	US-6,305,517	10-2001	Cole, Jeffrey Jay	192/87.15
	Е	US-3,977,272	08-1976	Neumann, Guenter J.	475/281
	F	US-			
	G	US-			
	Н	US-	*		
	ı	US-			,
	J	US-		·	
	κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2003/106868 A1	12-2003	WIPO	Onishi et al.	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	Not 17/12/11 Booding.110							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	٧							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.